## Notice of References Cited

Application/Control No. 10/797,786	Reexaminati	Applicant(s)/Patent Under Reexamination OKANAKA ET AL.		
Examiner	Art Unit			
Christopher P. Schwartz	3683	Page 1 of 1		

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-4,763,884	08-1988	Matsui et al.	267/140.12
	В	US-4,971,456	11-1990	Hori, Hiroaki	384/99
	С	US-4,997,168	03-1991	Kato, Rentaro	267/140.13
	D	US-5,080,330	01-1992	Nanno, Takanobu	267/140.12
	Ε	US-5,190,269 a	03-1993	Ikeda et al.	267/140.12
	F	US-5,259,598 a	11-1993	Hibi et al.	267/140.13
	G	US-5,269,498 a	12-1993	Bretaudeau et al.	267/140.13
	Н	US-6,390,458 b2	05-2002	Okanaka et al.	267/140.11
	ı	US-6,523,814 b2	02-2003	Kodama et al.	267/140.13
	J	US-6,799,753 b2	10-2004	Okanaka et al.	267/140.13
	к	US-			
	L	US-			
	м	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Q					
	R	•				
	S		,			
	Т					

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	>	
	w	
	х	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.